

## From Nanometer to Atomic Resolution X-ray EDS analysis of Al in Ni-rich Layered Oxide Li-Ion Cathodes

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Ni-rich  $\text{LiNi}_{0.8}\text{Co}_{0.15}\text{Al}_{0.05}\text{O}_2$ , commonly known as NCA, is one of the highest capacity cathode materials currently being used commercially. Although for safety reasons, the commercial use of the NCA cathodes is limited to 3.8V, but its relative stability at high charge voltage makes it a promising candidate for high capacity Li-ion batteries [1]. This structural stability of NCA at high voltage is unlike its parent compounds  $\text{LiNiO}_2$  and  $\text{LiCoO}_2$ , both of which degrade rapidly at high voltages (usually > 4.5V). It has long been argued that Al plays a critical role in structural stability of NCA, but the exact manner in which Al stabilizes the structure is not known yet. A quantitative determination of the distribution of Al in cathodes held at high voltages, both at the surface and inside the particle, is key to understand the role it plays. Although the segregation behavior of Al [2] in high 50% Al content LNA has been studied quantitatively, its behavior at low Al content and at state of charge is at present unknown. The low concentration of Al in NCA makes quantitative analysis difficult. In this work, we are studying the distribution of Al by X-ray energy-dispersive spectroscopy (EDS) at both nanometer and atomic levels in a series of compounds starting with  $\text{LiAlO}_2$  (LAO),  $\text{LiNi}_{0.8}\text{Al}_{0.2}\text{O}_2$  (LNA), and  $\text{LiNi}_{0.8}\text{Co}_{0.15}\text{Al}_{0.05}\text{O}_2$  (NCA). This study includes pristine condition as well as electrochemically stressed at a high voltage of 4.75V with  $\text{LiPF}_6$  and  $\text{LiBF}_4$  electrolytes.

Nanometer resolution X-ray EDS mapping and STEM imaging were performed at Brookhaven National Laboratory in a FEI Talos<sup>TM</sup> microscope. Atomic resolution EDS measurements were performed in a FEI Titan<sup>TM</sup> G2 80-200 STEM with a Cs probe corrector at Sandia National Laboratories. Both microscopes were fitted with four super EDS Bruker detectors.

The Al composition as a function of distance from the edge of the particle is shown in Figure 1 for (a) pristine NCA and for electrochemically stressed NCA at 4.75V and 60°C for 10 hrs with (b)  $\text{LiPF}_6$  and (c)  $\text{LiBF}_4$  electrolytes. In all cases there is Al enrichment at the surface. For pristine NCA the Al enrichment decreases to an Al composition about 4.5% below the surface. However, at 4.75V, the Al composition decreases to 2.5 and 3 at% Al for  $\text{LiPF}_6$  and  $\text{LiBF}_4$  respectively. So, under chemically stressed conditions, some Al has dissolved from the electrode. This kind of preferential distribution of Al is also observed in pristine  $\text{LiNi}_{0.8}\text{Al}_{0.2}\text{O}_2$  (Figure 1d). The Al is distributed preferentially at the corners and some facets of the particle. The core of the particle remains essentially Al deficient. The atomic resolution HAADF STEM image of one such particle is shown in Figure 2a. The layered LNA compound is electron beam sensitive and in order to obtain sufficient X-ray counts for obtaining atomic resolution EDS maps, a summation of all unit cell within the map has been performed as described previously [3]. The averaged HAADF STEM image is shown in Figure 2b with the corresponding atomic-scale EDS maps for (c) O-K, (d) Ni-K and (e) Al-K. It can be seen that Ni and Al occupy the same octahedral sites. The X-ray intensity profiles for Ni and Al are shown in Figure 2f. For Ni, the intensity profile is sharp while some broadening in the Al position is observed which could be due to smaller Al-O distance for some Al positions as compared to Ni-O distance. After the second EDS map from the same region, some Ni atoms have migrated (induced by the electron beam) to the Li layer position as revealed by the small peak between the Ni positions. Further work is in progress to

determine in more details the Al positions in LNA and to determine by EELS the chemical state of Al in the same area of the particles [4].

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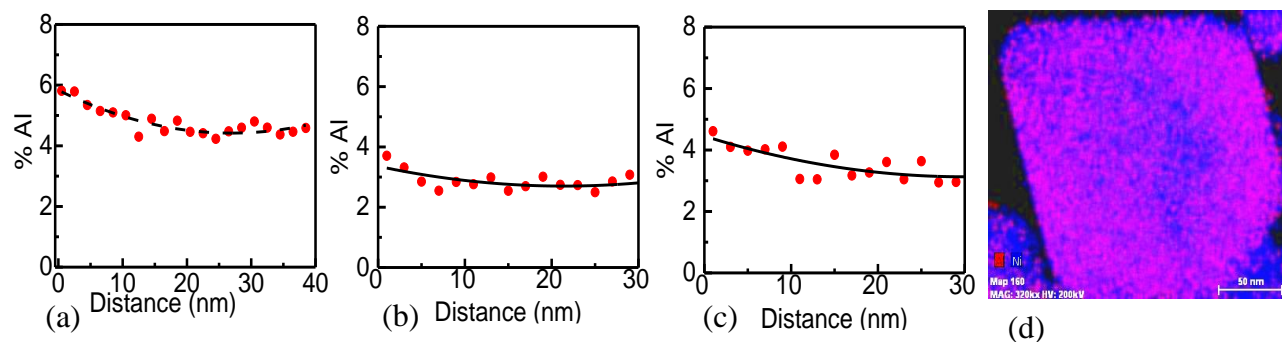


Figure 1. (a-c) Variation of Al content in NCA as a function of distance from the edge of (a) NCA pristine, (b) NCA held for 10 hrs at 4.75 V in LiPF<sub>6</sub> electrolyte and (c) NCA held for 10 hrs at 4.75 V in LiBF<sub>4</sub> electrolyte. (d) Quantitative X-ray EDS map in pristine LNA showing Al enrichment at the surface. (Red represents Al and blue represents Ni)

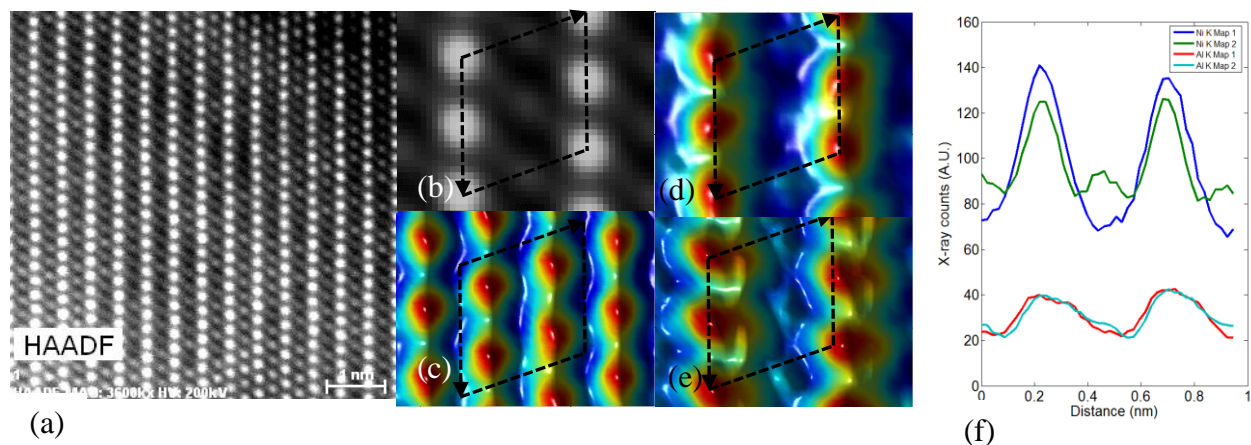


Figure 2. (a) HAADF-STEM image of LNA with (b) unit cell averaged STEM image and corresponding atomic resolution X-ray EDS maps of (c) O-K, (d) Ni-K and (e) Al-K and in (f) the intensity profile of Ni-K and Al-K after first and second scan map